

EAST: 110-789094 - Watermaster v. p1			
File View Edit Tools Window Help			
DRAFTS			
A B C D E F G H I J K L M N O P Q R S T U V W X Y Z			
Write	Search Text	DB	Time Stamp
1 6733 chip same wafer same test		USPAT; US-PGPUB; 2004/08/27	
		EPO; JPO; 11:02	
		DERWENT; IBM_TDB	
2 14218 (clean or cleaning or cleaned) with (probe or needle or pin)		USPAT; US-PGPUB; 2004/08/27	
		EPO; JPO; 11:03	
		DERWENT; IBM_TDB	
3 102 ((chip same wafer same test) and ((clean or cleaning or cleaned) with (probe or needle or pin)))		USPAT; US-PGPUB; 2004/08/27	
		EPO; JPO; 11:33	
		DERWENT; IBM_TDB	
4 10042 257/48, E21.521, E21.524.ccls. 438/11, 14, 15, 17, 18, FOR101, FOR142.ccls. 716/4-6.ccls.		USPAT; US-PGPUB; 2004/08/27	
		EPO; JPO; 11:29	
		DERWENT; IBM_TDB	
5 13 (((chip same wafer same test) and ((clean or cleaning or cleaned) with (probe or needle or pin))) and (257/48, E21.521, E21.524.ccls. 438/11, 14, 15, 17, 18, FOR101, FOR142.ccls. 716/4-6.ccls.))		USPAT; US-PGPUB; 2004/08/27	
		EPO; JPO; 13:11	
		DERWENT; IBM_TDB	
6 1 ((chip same wafer same test) and ((clean or cleaning or cleaned) with (probe or needle or pin))) and database		USPAT; US-PGPUB; 2004/08/27	
		EPO; JPO; 11:33	
		DERWENT; IBM_TDB	
7 29 (((chip same wafer same test) and ((clean or cleaning or cleaned) same (probe or needle or pin))) and (257/48, E21.521, E21.524.ccls. 438/11, 14, 15, 17, 18, FOR101, FOR142.ccls. 716/4-6.ccls.))		USPAT; US-PGPUB; 2004/08/27	
		EPO; JPO; 13:12	
		DERWENT; IBM_TDB	
8 5 (((chip same wafer same test) and ((clean or cleaning or cleaned) same (probe or needle or pin))) and (257/48, E21.521, E21.524.ccls. 438/11, 14, 15, 17, 18, FOR101, FOR142.ccls. 716/4-6.ccls.)) and database		USPAT; US-PGPUB; 2004/08/27	
		EPO; JPO; 13:12	
		DERWENT; IBM_TDB	
Find Open Return			

EAST 8/27/04

BEST AVAILABLE COPY